

Conductance and gating effects at sputtered oxide interfaces Y_{in} , C.

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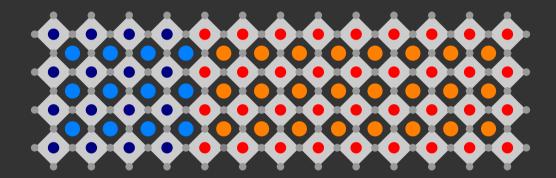
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Chunhai Yin